

General Description

The AO4904 uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. The two MOSFETs make a compact and efficient switch and synchronous rectifier combination for use in DC-DC converters. A Schottky diode is co-packaged in parallel with the synchronous MOSFET to boost efficiency further. Standard Product AO4904 is Pb-free (meets ROHS & Sony 259 specifications). AO4904L is a Green Product ordering option. AO4904 and AO4904L are electrically identical.

Features

V_{DS} (V) = 30V

I_D = 6.9A (V_{GS} = 10V)

$R_{DS(ON)}$ < 27m Ω (V_{GS} = 10V)

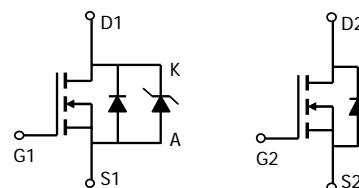
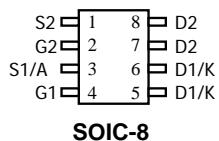
$R_{DS(ON)}$ < 32m Ω (V_{GS} = 4.5V)

$R_{DS(ON)}$ < 50m Ω (V_{GS} = 2.5V)



SCHOTTKY

V_{DS} (V) = 30V, I_F = 3A, V_F =0.5V@1A



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | MOSFET | Schottky | Units |
|---|----------------|------------|------------|-------|
| Drain-Source Voltage | V_{DS} | 30 | | V |
| Gate-Source Voltage | V_{GS} | ± 12 | | V |
| Continuous Drain Current ^A | I_D | 6.9 | | A |
| | | 5.8 | | |
| Pulsed Drain Current ^B | I_{DM} | 40 | | |
| Schottky reverse voltage | V_{KA} | | 30 | V |
| Continuous Forward Current ^A | I_F | 3 | | A |
| | | 2 | | |
| Pulsed Forward Current ^B | I_{FM} | 40 | | |
| Power Dissipation | P_D | 2 | 2 | W |
| | | 1.44 | 1.44 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | -55 to 150 | °C |

| Parameter: Thermal Characteristics MOSFET | Symbol | Typ | Max | Units |
|---|-----------|------|------|-------|
| Maximum Junction-to-Ambient ^A | R_{0JA} | 48 | 62.5 | °C/W |
| Maximum Junction-to-Ambient ^A | | 74 | 110 | |
| Maximum Junction-to-Lead ^C | R_{0JL} | 35 | 40 | |
| Thermal Characteristics Schottky | | | | |
| Maximum Junction-to-Ambient ^A | R_{0JA} | 47.5 | 62.5 | °C/W |
| Maximum Junction-to-Ambient ^A | | 71 | 110 | |
| Maximum Junction-to-Lead ^C | R_{0JL} | 32 | 40 | |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|------------|----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$ | 30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=24\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | 1 5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$ | | | 100 | nA |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$ | 0.7 | 1 | 1.4 | V |
| $I_{D(\text{ON})}$ | On state drain current | $V_{GS}=4.5\text{V}, V_{DS}=5\text{V}$ | 25 | | | A |
| $R_{DS(\text{ON})}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}, I_D=6.9\text{A}$ $T_J=125^\circ\text{C}$ | | 22.6 33 | 27 40 | $\text{m}\Omega$ |
| | | $V_{GS}=4.5\text{V}, I_D=6.0\text{A}$ | | 27 | 32 | $\text{m}\Omega$ |
| | | $V_{GS}=2.5\text{V}, I_D=5\text{A}$ | | 42 | 50 | $\text{m}\Omega$ |
| | | | | | | |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}, I_D=5\text{A}$ | 12 | 16 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=1\text{A}$ | | 0.71 | 1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 3 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$ | | 846 | 1050 | pF |
| C_{oss} | Output Capacitance | | | 96 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 67 | | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | | 1.24 | 3.6 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q_g | Total Gate Charge | $V_{GS}=4.5\text{V}, V_{DS}=15\text{V}, I_D=6.9\text{A}$ | | 9.6 | 12 | nC |
| Q_{gs} | Gate Source Charge | | | 1.65 | | nC |
| Q_{gd} | Gate Drain Charge | | | 3 | | nC |
| $t_{D(\text{on})}$ | Turn-On DelayTime | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=2.2\Omega$, $R_{\text{GEN}}=3\Omega$ | | 5.7 | 8.55 | ns |
| t_r | Turn-On Rise Time | | | 13 | 6.2 | ns |
| $t_{D(\text{off})}$ | Turn-Off DelayTime | | | 37 | 40 | ns |
| t_f | Turn-Off Fall Time | | | 4.2 | 5.5 | ns |
| t_{rr} | Body Diode Reverse Recovery time | $I_F=5\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 15.5 | 20 | ns |
| Q_{rr} | Body Diode Reverse Recovery charge | $I_F=5\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 7.9 | | nC |
| SCHOTTKY PARAMETERS | | | | | | |
| V_F | Forward Voltage Drop | $I_F=1.0\text{A}$ | | 0.45 | 0.5 | V |
| I_{rm} | Maximum reverse leakage current | $V_R=30\text{V}$ | | 0.007 | 0.05 | mA |
| | | $V_R=30\text{V}, T_J=125^\circ\text{C}$ | | 3.2 | 10 | |
| | | $V_R=30\text{V}, T_J=150^\circ\text{C}$ | | 12 | 20 | |
| C_T | Junction Capacitance | $V_R=15\text{V}$ | | 37 | | pF |

A: The value of R_{DJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R_{DJA} is the sum of the thermal impedance from junction to lead R_{JUL} and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

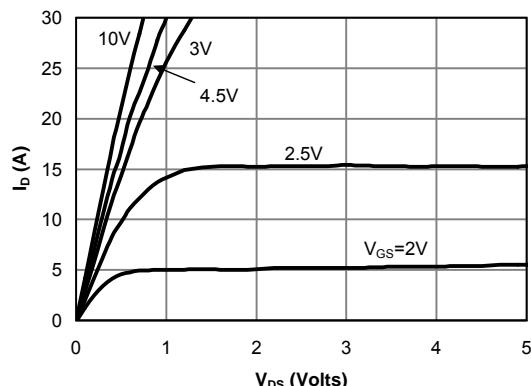


Fig 1: On-Region Characteristics

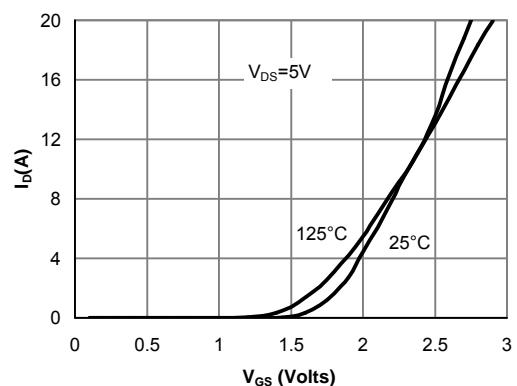


Figure 2: Transfer Characteristics

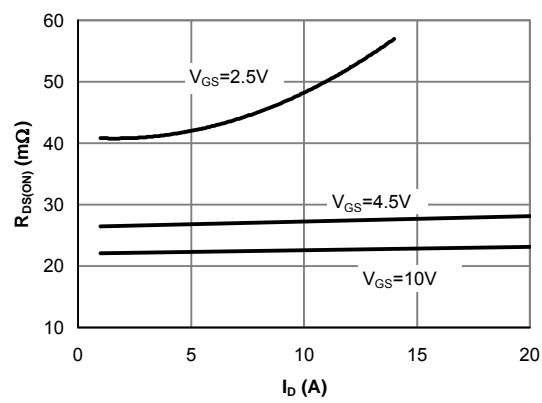


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

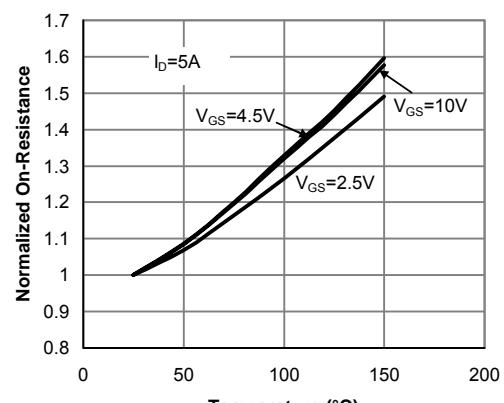


Figure 4: On resistance vs. Junction Temperature

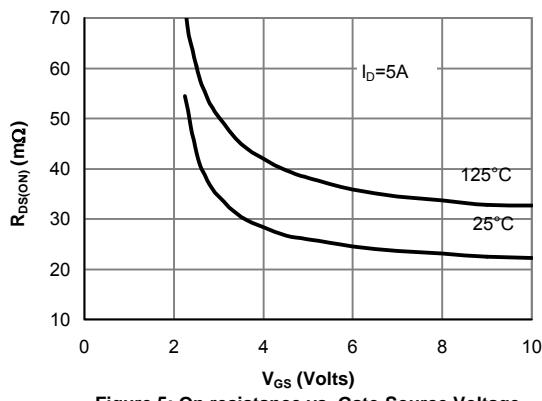


Figure 5: On resistance vs. Gate-Source Voltage

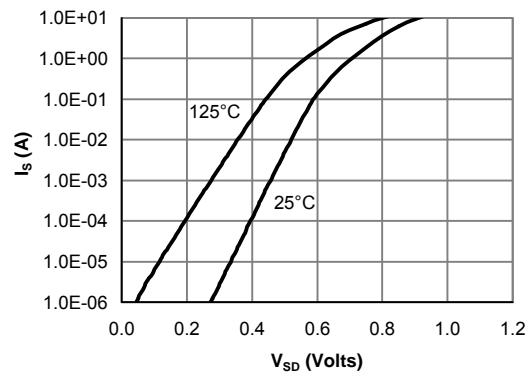


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

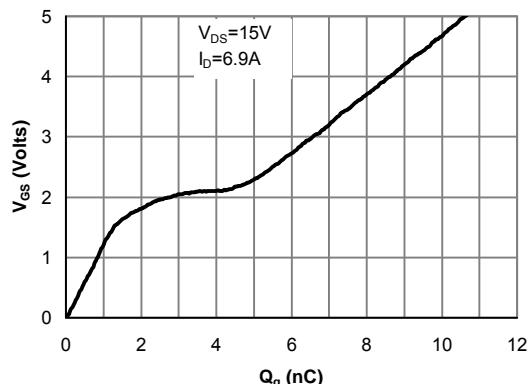


Figure 7: Gate-Charge Characteristics

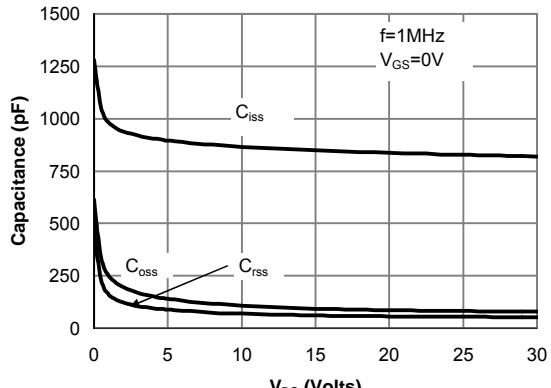


Figure 8: Capacitance Characteristics

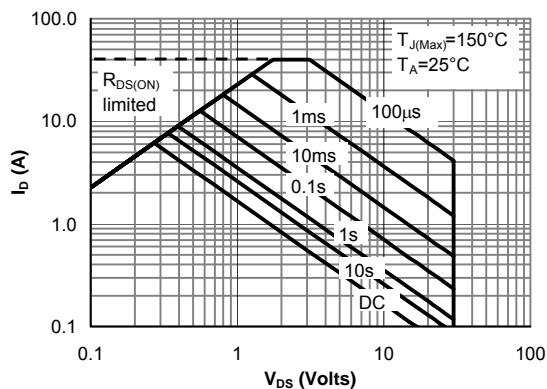


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

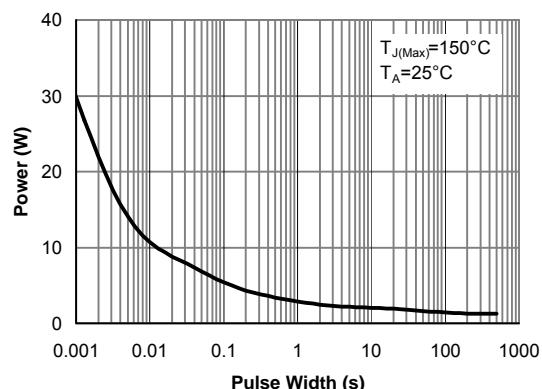


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

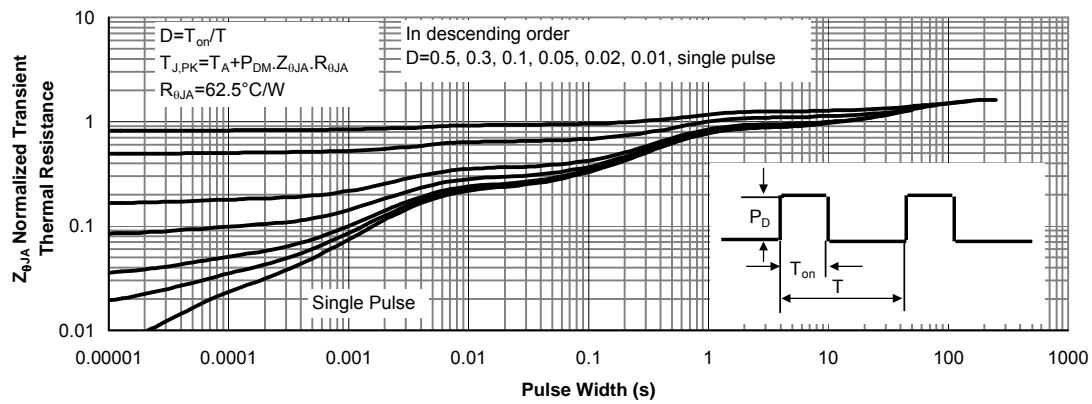


Figure 11: Normalized Maximum Transient Thermal Impedance

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: SCHOTTKY

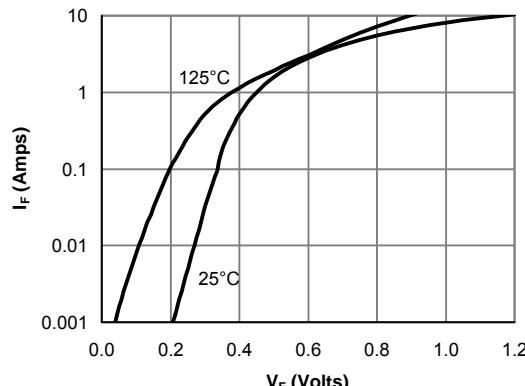


Figure 12: Schottky Forward Characteristics

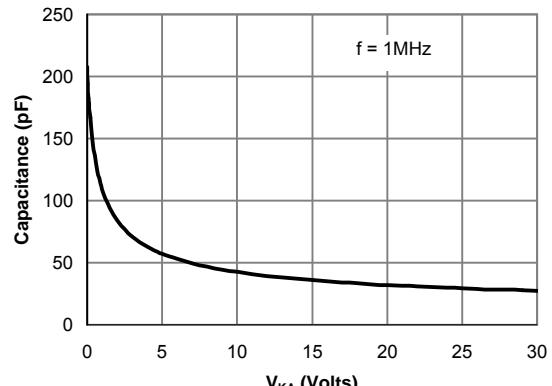


Figure 13: Schottky Capacitance Characteristics

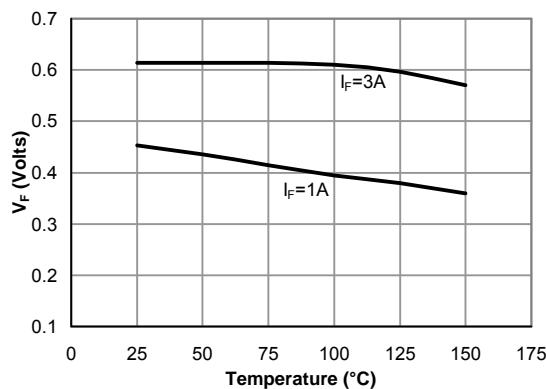


Figure 14: Schottky Forward Drop vs. Junction Temperature

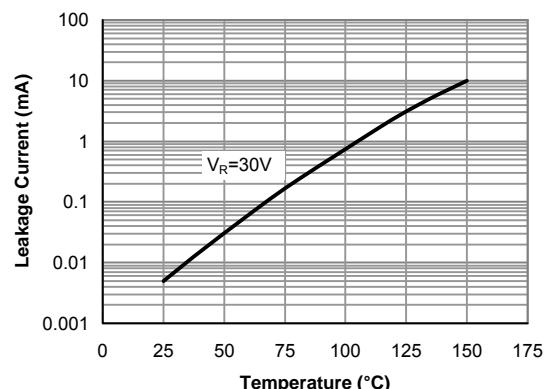


Figure 15: Schottky Leakage current vs. Junction Temperature

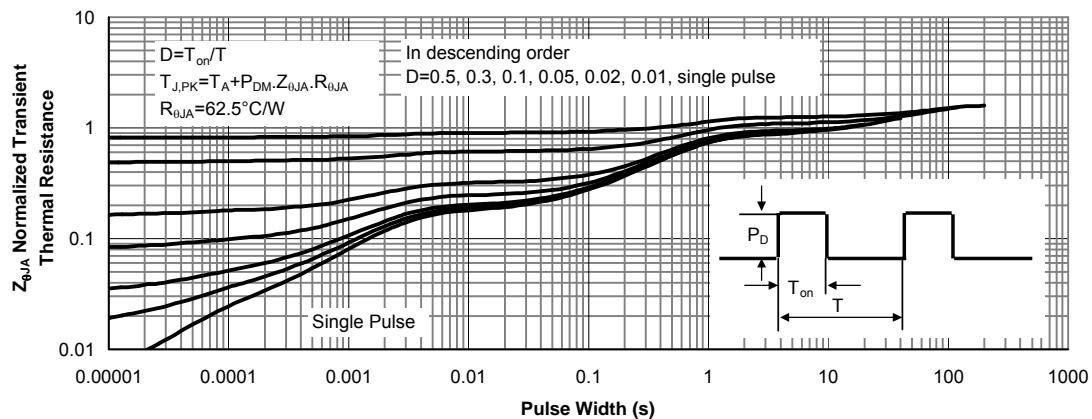


Figure 15: Schottky Normalized Maximum Transient Thermal Impedance